

# **SLD90N10G 100V N - Channel MOSFET**

## **General Description**

This Power MOSFET is produced using Msemitek's advanced Shielding Gate MOSFET technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as DC/DC converters and high efficiency switching for power management in portable and battery operated products.

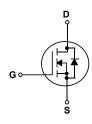
### Features

- N-Channel:100V 90A
  - $\begin{array}{l} R_{DS(on)Typ} = 6.2m\Omega @VGS = 10 \ V \\ R_{DS(on)Typ} = 8.6m\Omega @VGS = 4.5V \end{array}$

LD90N100

- Very Low On-resistance R<sub>DS(ON)</sub>
- Low Crss
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability





#### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter	SLD90N10G	Units V	
V <sub>DSS</sub>	Drain-Source Voltage	100		
lo	Drain Current - Continuous (T <sub>c</sub> = 25°C)	90	А	
	- Continuous (T <sub>c</sub> = 100°C	56	А	
IDM	Drain Current - Pulsed	(Note 1)	270	А
V <sub>GSS</sub>	Gate-Source Voltage		±20	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	80	mJ	
PD	Power Dissipation (T <sub>c</sub> = 25°C)	250	W	
R <sub>ejc</sub>	Thermal Resistance, Junction to Case	0.5	°C/W	
Tj, Tstg	Operating and Storage Temperature Range	-55 to +150	°	
ΤL	Maximum lead temperature for soldering pu 1/8" from case for 5 seconds	300	°C	

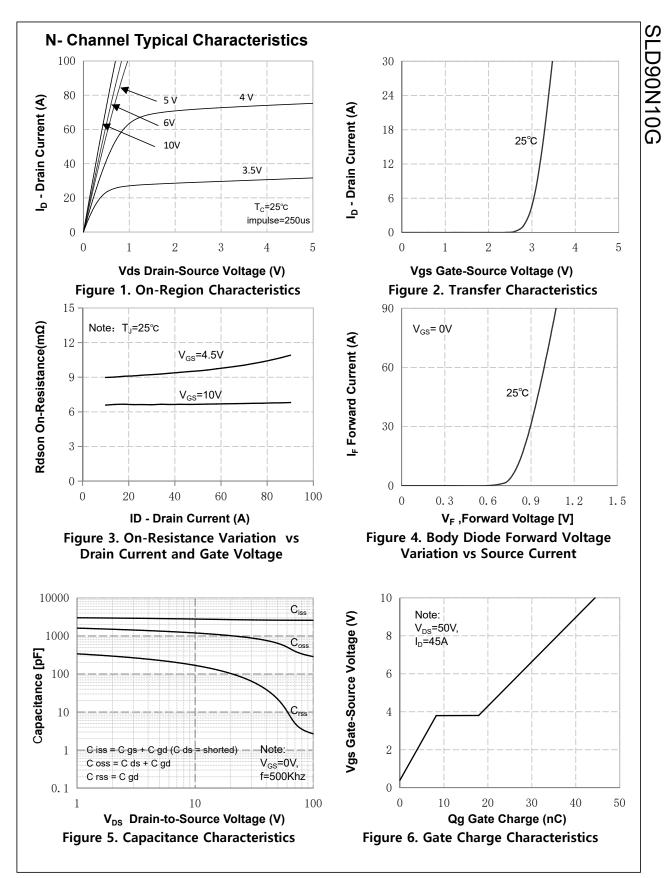
\* Drain current limited by maximum junction temperature.

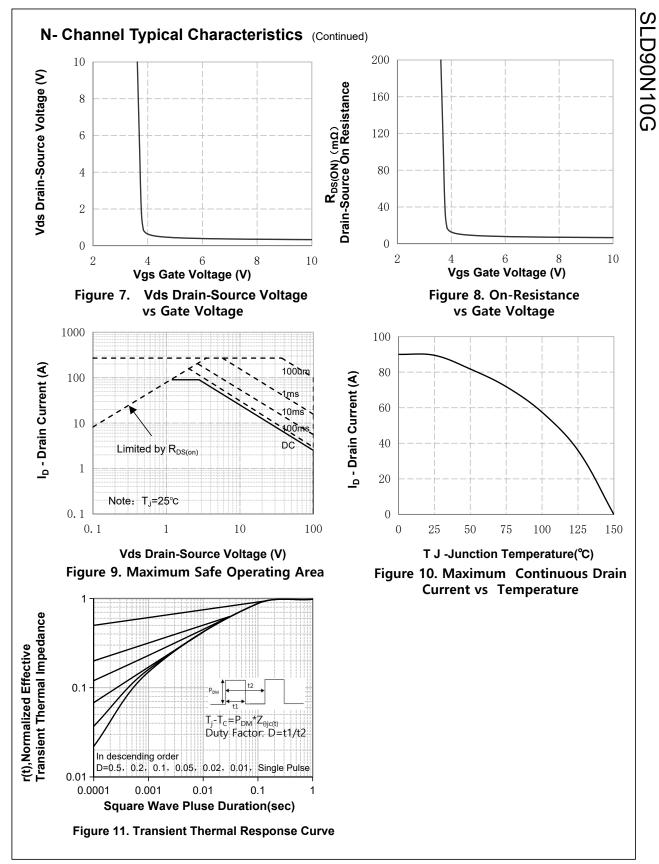
Part Number		Top Marking	Package		Packing Method		MOQ		QTY		
SLD90N10G		SLD90N10G	D-Pak		Tape & F	Reel	25	2500		25000	
Elect	rical Ch	aracteristics	ī	「 <sub>C</sub> = 25°C ∣	unless otherwise n	oted					
Symbol		Parameter			Test Condition	s	Min	Тур	Max	Units	
Off Cha	aracterist	tics									
BV <sub>DSS</sub>	Drain-Sou	rce Breakdown Voltage		$V_{cc} = 0$	V lp = 250 µA		100			V	
		5		$V_{GS} = 0 V, I_D = 250 uA$					1		
IDSS		Zero Gate Voltage Drain Current			$V_{DS} = 100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$					uA	
IGSSF	,	Leakage Current, For		$V_{GS} = 20V, V_{DS} = 0V$					100	nA	
I <sub>GSSR</sub>	Gate-Body	Gate-Body Leakage Current, Reverse			20 V, V <sub>DS</sub> = 0 V				-100	nA	
On Cha	aracterist	ics									
V <sub>GS(th)</sub>	Gate Three	e Threshold Voltage		V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 uA			1.5	2.0	2.5	V	
-	Static Drain-Source On-Resistance		V <sub>GS</sub> =10 V, I <sub>D</sub> = 20A V <sub>GS</sub> =4.5V, I <sub>D</sub> = 20A				6.2	7.7	m()		
R <sub>DS(on)</sub>							8.6	10			
Dynam	ic Chara	cteristics									
Ciss	Input Capa	acitance		V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 0 V, f = 500KHz			2600	-	pF		
Coss	Output Ca	pacitance					641	-	pF		
C <sub>rss</sub>	Reverse T	ransfer Capacitance		1 - 500				22	-	pF	
Switch	ing Char	acteristics									
	-			1						1	
t <sub>d(on)</sub>	Turn-On D Turn-On R	,						20 16		ns	
t <sub>r</sub> t <sub>d(off)</sub>	Turn-Off D				V, V <sub>DS</sub> =50V, )  I⊳=45A Ti=25°	C (Note 3)		32		ns ns	
t <sub>f</sub>	Turn-Off F			$R_G = 1\Omega$ , $I_D = 45A$ Tj=25°C (Note 3)			32 8		ns		
Q <sub>a</sub>	Total Gate			N/ - F/				44.4		nC	
Qgs	Gate-Sour	ů.		V <sub>DS</sub> = 50 V <sub>GS</sub> = 1	)V, I⊳ =45A, 0V	(Note 3)		9.1		nC	
Q <sub>gd</sub>	Gate-Drain	•		• 65		(		9.4		nC	
5											
Drain-S	Source Di	iode Characterist	ics ar	nd Max	imum Rating	gs					
ls	Maximum	Continuous Drain-Sour	Prain-Source Diode Forward Current					90	A		
Ism	Maximum	Pulsed Drain-Source D						270	Α		
13171		ource Diode Forward V									

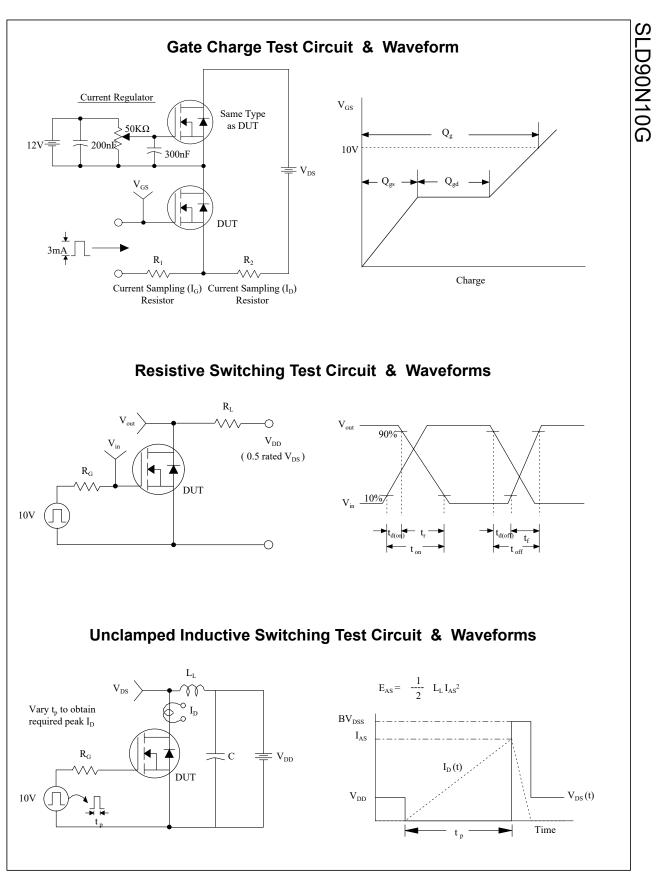
Notes:

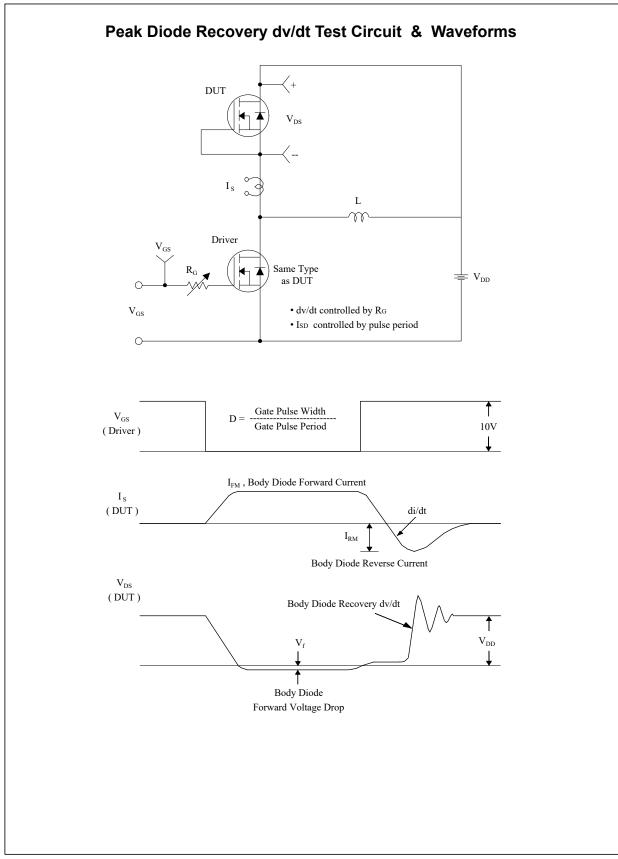
Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
EAS condition: T J=25°C, V DD =20V, VG =10V, L=0.5mH.
Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%

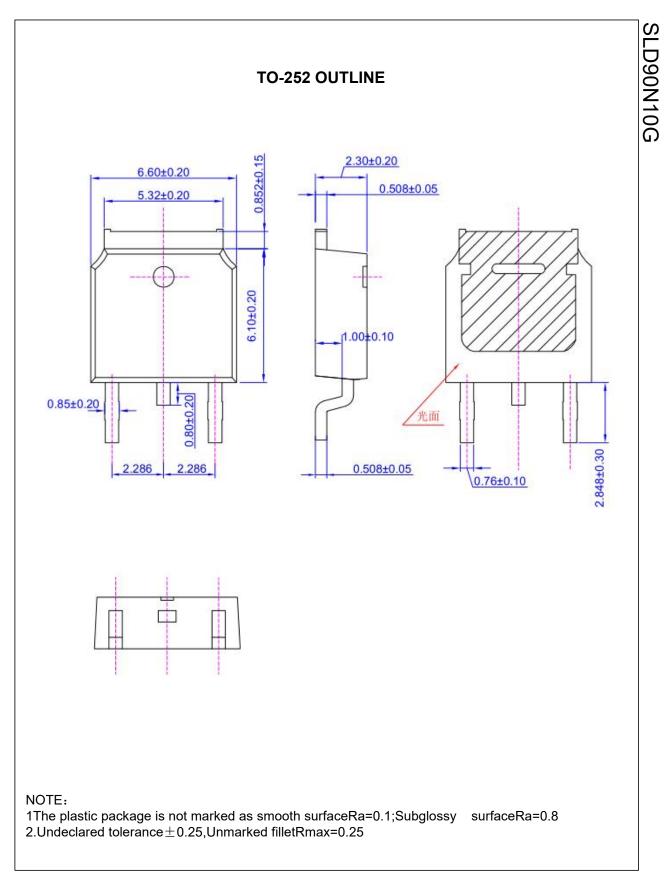
SLD90N10G











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